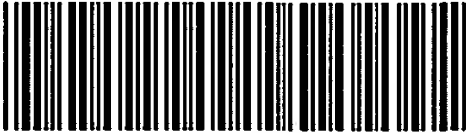


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/899,422	HAUPTMANN ET AL.	
	Examiner	Art Unit	
	Eileen O'Hara	1646	

SEARCHED			
Class	Subclass	Date	Examiner
530	350	5/11/2005	
536	23.5		
514	2 8		
514	12		
424	85.1		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
530	350	5/11/2005	EOH
514	12		
424	85.1		
STIC SEQ ID NOS: 3 and 4			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Patentability Conference with Tony Caputa and Elizabeth Kemmerer	5/3/2005	EOH
Updated Patent Databases STIC - SEQ ID NOS: 3 and 4	5/11/2005	EOH